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## Selective construction of junctions on different facets of BiVO<sub>4</sub> for enhancing photo-activity

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A novel ternary Ag/BiVO<sub>4</sub>/Co<sub>3</sub>O<sub>4</sub> hybrid photocatalyst was designed by constructing a metal–semiconductor junction and a p–n junction on electron-rich {010} facets and hole-rich {110} facets of BiVO<sub>4</sub>, respectively. The Ag/BiVO<sub>4</sub>/Co<sub>3</sub>O<sub>4</sub> hybrid photocatalyst exhibits enhanced photocatalytic activity for rhodamine B degradation, which is over 8 times that of bare BiVO<sub>4</sub> under simulated solar light. It was proven that the combination of a metal–semiconductor junction and a p–n junction further promotes the charge transferring across the interface, and results in an additional effect of two single junctions for improving photo-activity. This research provides a deep insight about the co-working mechanism between the two heterojunctions, and it will propose a new concept for designing a highly efficient photo-catalyst system.

### 1. Introduction

Water purification is quite important for human health.<sup>1–3</sup> Over recent decades, numerous effective methods have been widely used for water purification, including chlorination, ozonization, UV radiation and so forth.<sup>4–7</sup> However, these treatments have some disadvantages, such as the production of toxic by-products, transport and storage of chemicals as well as high energy needs.<sup>7</sup> Photocatalysis has been proven to be a promising process for water purification due to its advantages such as non-selective, and no need of additional chemicals.<sup>8–11</sup>

Bismuth vanadate (BiVO<sub>4</sub>) has received much attention among the visible light-active photo-catalysts.<sup>12–14</sup> BiVO<sub>4</sub> has three main crystal structures, tetragonal zircon, tetragonal scheelite and monoclinic scheelite. The monoclinic scheelite phase of BiVO<sub>4</sub> has a band gap of 2.4 eV and has been demonstrated to exhibit much higher photo-catalytic activity in visible light than the other two phases.<sup>15</sup> However, the photo-activity of BiVO<sub>4</sub> alone is not very impressive because of the relatively fast recombination of photogenerated electron–hole pairs.<sup>16</sup>

Designing and constructing heterojunctions, such as p–n junctions, metal–semiconductor (m–s) junctions and so forth, is an effective way to improve the electron–hole separation.<sup>17</sup> Many researchers have reported the advantages of heterojunctions in enhancing the activity of a photocatalyst.<sup>17–20</sup> Recently, multi-junction photocatalyst systems were designed to further improve photocatalytic activity, such as Ag/Ag<sub>3</sub>PO<sub>4</sub>/BiPO<sub>4</sub> (ref. 21)

and Cu–TiO<sub>2</sub>–Cu<sub>2</sub>O<sup>22</sup> hybrid catalysts. In the present research, the band position and the Fermi level were firstly taken into consideration for selecting interfacial junction materials, since the matching of band energy between two components is one of the most important conditions for designing efficient junctions.<sup>17</sup> Actually, the distribution of holes and electrons over the semi-conductor surface under irradiation is an essential factor that should be considered for selecting the construction location of junctions. However, junctions were usually constructed over the semi-conductor surface randomly without considering the location in the present research. In this case, the construction of junctions can hardly achieve optimal hole–electron separation efficiency, and it is also hard to anticipate the co-working mechanism between different junctions for electron–hole separation.

Recently, it was reported that photo-generated electrons and holes can be spatially separated onto different facets of BiVO<sub>4</sub>.<sup>23</sup> Accordingly, we can selectively construct suitable junctions on different facets of BiVO<sub>4</sub> for improving photoactivity based on the charge separation among different facets. The semiconductor p–n junction is an effective architecture for the highly efficient charge collection and separation. BiVO<sub>4</sub> is an n-type semiconductor, so it is reasonable to design p–n junctions on hole-rich facets of BiVO<sub>4</sub> to facilitate the transfer of holes to the p-type semiconductor, and thus avoid the recombination of holes with electrons in BiVO<sub>4</sub>. To deposit noble metal nanoparticles on the surface of the semiconductor is another effective method to create a space-charge separation region. These metal nanoparticles can act as a sink for photo-induced electrons, thereby facilitating the charge separation and enhancing the photocatalytic activity. For their high activity as the sink for photo-induced electrons, a metal–semiconductor (m–s) junction

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can be constructed over electron-rich facets of  $\text{BiVO}_4$  to improve its photoactivity. So far, various noble metals such as platinum, aurum, and silver have been deposited on semiconductors to improve the photoactivity. Among them, silver is an attractive one because of its low cost and as well as its effective electron trapping ability.<sup>24</sup>

In this research, silver and cobalt oxide were selectively deposited onto electron-rich facets and hole-rich facets of  $\text{BiVO}_4$  crystals, thereby constructing the metal–semiconductor junction and the p–n junction over  $\text{BiVO}_4$ . Rhodamine B degradation was utilized as a probe to evaluate the photo-activity of as-fabricated photocatalysts. It was demonstrated that the photoactivity of  $\text{BiVO}_4$  with the metal–semiconductor junction and the p–n junction selectively constructed on {010} and {110} facets of  $\text{BiVO}_4$  crystals was dramatically enhanced compared with the pure  $\text{BiVO}_4$ , and the combination of the two junctions results in the additional effect of two single junctions for improving photo-activity. This work will give a deep insight to understand the co-working mechanism of multi-junctions in a hybrid photocatalyst system, and it will provide a general concept for constructing highly effective photocatalysts.

## 2. Experimental section

### 2.1 Synthesis of photocatalysts

**2.1.1 Synthesis of  $\text{BiVO}_4$ .** A  $\text{BiVO}_4$  crystal sample was synthesized by a hydrothermal method. In a typical procedure, the precursors  $\text{Bi}(\text{NO}_3)_3 \cdot 5\text{H}_2\text{O}$  (50 mmol) and  $\text{NH}_4\text{VO}_3$  (50 mmol) were dissolved in 10 mL of 4.0 M  $\text{HNO}_3$  solution and 10 mL 2.0 M  $\text{NaOH}$  solution, respectively. These two solutions were mixed slowly to form a yellowish suspension, and the pH value of the solution was then adjusted to be 1.0 with sodium hydroxide under stirring. After stirring for 0.5 h, the suspension was transferred into a Teflon-lined stainless steel autoclave with a capacity of 25 mL, and reacted at 150 °C for 12 h. After hydrothermal reaction, the precipitate was washed and centrifuged in de-ionized water three times, and finally dried overnight at 60 °C.

**2.1.2 Facet-selective photo-deposition of silver and/or cobalt oxide.** For the facet-selective photo-deposition on  $\text{BiVO}_4$ , similar procedures were performed for single silver reductive-deposition, single cobalt oxide oxidative-deposition, and simultaneous silver reductive-deposition and cobalt oxide oxidative-deposition. Typically, 0.1 g of  $\text{BiVO}_4$  powder was dispersed into 50 mL of aqueous solution with a calculated amount of metal precursors upon stirring. Photo-deposition was performed for 4 h at room temperature, using a 300 W Xe lamp (Max-302, Asahi Spectra, Japan) as a light source. After photo-deposition, the  $\text{BiVO}_4$  sample was filtered, repeatedly washed with de-ionized water, and finally dried at 40 °C in a vacuum oven for 12 h. For single silver reductive-deposition, a 2 g  $\text{L}^{-1}$   $\text{AgNO}_3$  solution with a volume of 50 mL was used as the precursor solution, and the as-obtained sample after photo-deposition was denoted as  $\text{BiVO}_4\text{-Ag}$ . The single cobalt oxide oxidative-deposition was performed in a 50 mL solution mixed with 1.456 g  $\text{L}^{-1}$   $\text{Co}(\text{NO}_3)_2$  and 4 g  $\text{L}^{-1}$   $\text{NaIO}_3$ , in which,  $\text{Co}(\text{NO}_3)_2$  was used as a precursor, and  $\text{NaIO}_3$

was used as an electron acceptor. The as-obtained sample after single oxidative-deposition was denoted as  $\text{BiVO}_4\text{-Co}_3\text{O}_4$ . The simultaneous silver reductive-deposition and cobalt oxide oxidative-deposition was performed by a two-step procedure. At first, the single cobalt oxide was deposited onto  $\text{BiVO}_4$  in a mixed solution with 1.456 g  $\text{L}^{-1}$   $\text{Co}(\text{NO}_3)_2$  and 4 g  $\text{L}^{-1}$   $\text{NaIO}_3$ . After 4 h of photo-deposition, the  $\text{BiVO}_4$  sample was filtered, washed with de-ionized water, and then transferred into 2 g  $\text{L}^{-1}$   $\text{AgNO}_3$  solution. After photo-deposition of Ag, the  $\text{BiVO}_4$  sample was filtered, repeatedly washed with de-ionized water, and finally dried at 40 °C in a vacuum oven for 12 h. The as-obtained sample after two-step deposition was denoted as  $\text{BiVO}_4\text{-Ag/Co}_3\text{O}_4$ .

### 2.2 Characterization

X-ray diffraction (XRD, Rigaku miniFlex-II desktop X-ray diffractometer, Cu-K $\alpha$  radiation with  $\lambda = 0.154056$  nm) was used to determine crystallinity and the crystal structure of the as-fabricated  $\text{BiVO}_4$  samples. The morphologies of the samples were observed using a scanning electron microscope (SEM, Hitachi Horiba S-4300) operated at 20 kV, and using a transmission electron microscope (TEM, JEOL. JEM-2010). The chemical states of Ag and Co on  $\text{BiVO}_4$  were determined using an X-ray photoelectron spectroscopy apparatus (PHI Quantera SXM). The energies of all spectra were shifted by correcting the C 1s peak to 284.6 eV for energy calibration. The room temperature photoluminescence (PL) of the powder samples was measured using a Hitachi F-7000 fluorescence spectrophotometer, using the 325 nm excitation of a Xenon lamp.

### 2.3 Dye photodegradation experiment

The photocatalytic efficiencies of all the prepared catalysts were evaluated by photodegrading rhodamine B (RhB) under simulated sunlight irradiation, which was sourced using a 300-W Xe lamp. In the degradation experiment, 100 mg of photocatalyst was suspended in 50 mL of aqueous solution with 10 mg  $\text{L}^{-1}$  RhB. Before irradiation, the RhB solution with a photocatalyst was stirred in the dark for 30 min to reach an adsorption/desorption equilibrium between RhB and the photocatalyst. During irradiation, approximately 3 mL of suspensions were collected at given time intervals and centrifuged to remove the photocatalyst particles. After that, the absorption spectra of the remaining sample solutions were recorded on the UV-vis equipment. Photocatalytic degradation over each sample was evaluated by the temporal concentration of RhB, which was determined in terms of their standard concentration *versus* absorbance curves and the changes in intensity of the absorbance at the corresponding absorption band maximum of RhB (554 nm).

## 3. Results and discussion

### 3.1 Morphology and composition characterization

X-ray diffraction was used to determine crystallinity and the crystal structure of the as-fabricated  $\text{BiVO}_4$  samples. According to the X-ray diffraction patterns of as-prepared  $\text{BiVO}_4$  powder

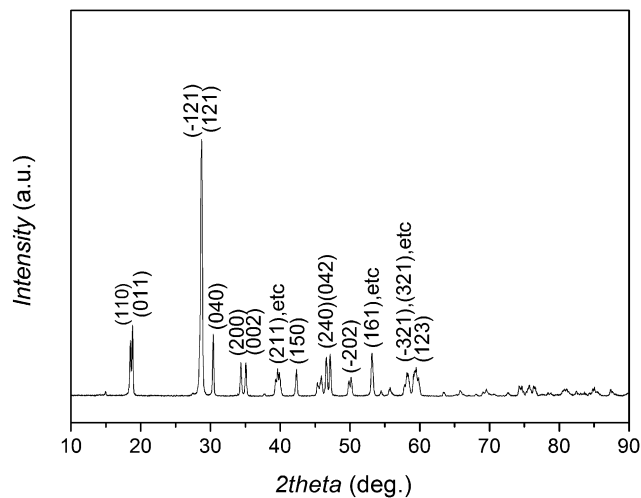


Fig. 1 X-ray diffraction pattern of as-prepared monoclinic sheelite  $\text{BiVO}_4$  powder.

(Fig. 1), it is indicated that the as-prepared  $\text{BiVO}_4$  is a monoclinic sheelite according to the standard JCPDS card no. 14-0688.

Fig. 2 shows the morphologies of bare  $\text{BiVO}_4$  powder and  $\text{BiVO}_4$  powder deposited with Ag and  $\text{Co}_3\text{O}_4$  particles. It can be observed that the exposed facets of  $\text{BiVO}_4$  are mainly composed of two facets, which are denoted as  $\{010\}$  and  $\{110\}$  facets, respectively (Fig. 2a). After photo-reduction deposition in silver nitrate aqueous solution, Ag particles with diameters of around tens of nanometers were selectively deposited on the electron-rich  $\{010\}$  facets of  $\text{BiVO}_4$  (Fig. 2b). XPS was utilized to confirm the oxidation state of these Ag particles on  $\text{BiVO}_4$ . From Fig. 4a, Ag 3d peaks can be easily observed from the survey spectrum of

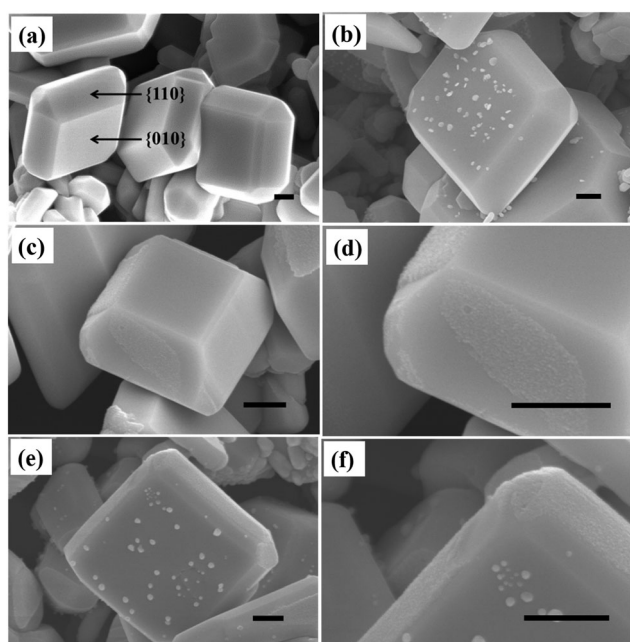


Fig. 2 Morphologies of as-prepared  $\text{BiVO}_4$  powder (a), sample  $\text{BiVO}_4\text{-Ag}$  (b), sample  $\text{BiVO}_4\text{-Co}_3\text{O}_4$  (c and d) and sample  $\text{BiVO}_4\text{-Ag/Co}_3\text{O}_4$  (e and f). Scale bar = 500 nm.

sample  $\text{BiVO}_4\text{-Ag}$ . The high resolution of the Ag 3d spectrum (Fig. 4b) shows that two peaks appeared at 368.2 and 374.2 eV are well corresponded with Ag  $3d_{5/2}$  and Ag  $3d_{3/2}$  binding energies, respectively. The splitting of the 3d doublet is 6.1 eV, indicating the metallic nature of silver.<sup>25</sup> Thus, it is proven that the photo-generated electrons are spatially separated onto the  $\{010\}$  facets of  $\text{BiVO}_4$  under irradiation, and they are readily available for the reduction reaction of silver ions. It is expected that the photo-reduction of silver ions (eqn (1)) on  $\{010\}$  facets of  $\text{BiVO}_4$  is accompanied by the elimination of photo-generated holes on  $\{110\}$  facets by water oxidation (eqn (2)), which can be expressed as follows:

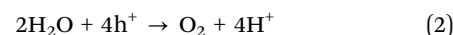
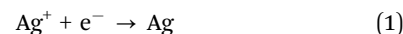


Fig. 2c and d show the morphologies of  $\text{BiVO}_4$  powder after deposition of  $\text{Co}_3\text{O}_4$  particles by the photo-oxidation deposition method in aqueous solution mixed with  $\text{Co}(\text{NO}_3)_2$  and  $\text{NaIO}_3$ . As we expect,  $\text{Co}_3\text{O}_4$  particles are selectively deposited on the  $\{110\}$  facets of  $\text{BiVO}_4$ . TEM images (Fig. 3a and b) confirm that the  $\text{Co}_3\text{O}_4$  particle layer with a thickness of about 20 nm was formed on the  $\{110\}$  facets of  $\text{BiVO}_4$  after photo-oxidation deposition. Fig. 3c shows the compositional scan profile (a blue line marked in the TEM image in Fig. 3b) of the sample  $\text{BiVO}_4\text{-Co}_3\text{O}_4$ . It clearly shows a strong Co signal at the edge of powder, further proving the selective deposition of Co species on  $\{110\}$  facets of  $\text{BiVO}_4$ . The high resolution of the Co 2p XPS spectrum of sample  $\text{BiVO}_4\text{-Co}_3\text{O}_4$  shows a doublet containing a low energy band (Co  $2p_{3/2}$ ) and a high energy band

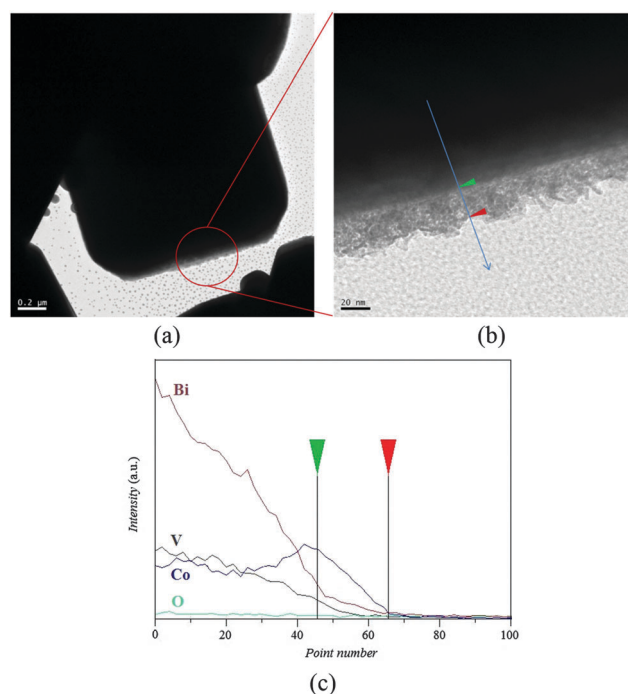


Fig. 3 TEM images of sample  $\text{BiVO}_4\text{-Co}_3\text{O}_4$  (a and b), and the EDS line scan of Bi, V, Co and O elements on sample  $\text{BiVO}_4\text{-Co}_3\text{O}_4$  along the blue line marked in (b) and (c).

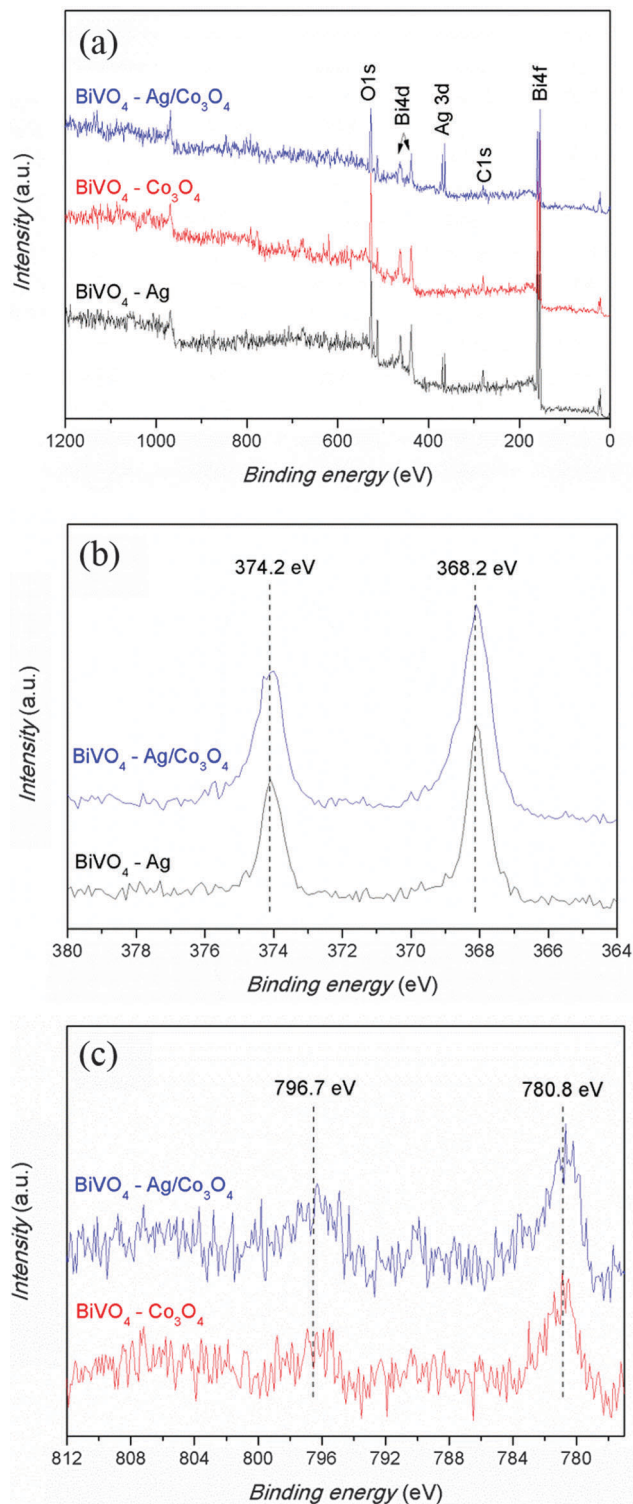
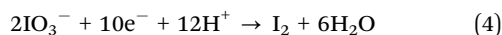
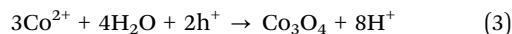


Fig. 4 XPS spectra of three kinds of photo-catalysts ( $\text{BiVO}_4\text{-Ag}$ ,  $\text{BiVO}_4\text{-Co}_3\text{O}_4$  and  $\text{BiVO}_4\text{-Ag/Co}_3\text{O}_4$ ): (a) survey spectra, and high resolution of (b) Ag 3d and (c) Co 2p spectra.

(Co  $2p_{1/2}$ ) at 780.8 and 796.7 eV (Fig. 4c), respectively, indicating that the deposited cobalt species can be ascribed to  $\text{Co}_3\text{O}_4$ .<sup>26</sup> Accordingly, it is expected that  $\text{Co}^{2+}$  ions are oxidized into  $\text{Co}_3\text{O}_4$  on the {110} facets of  $\text{BiVO}_4$  crystals with the assistance

of using  $\text{IO}_3^-$  as sacrificial electron acceptors. The reactions can be described as eqn (3) and (4):



After the selective photo-deposition of Ag and  $\text{Co}_3\text{O}_4$  particles on  $\text{BiVO}_4$ , we further investigated the photo-deposition of dual components (Ag and  $\text{Co}_3\text{O}_4$ ) using a two-step procedure including photo-oxidation deposition and the following photo-reduction deposition. Using this method, Ag and  $\text{Co}_3\text{O}_4$  particles were deposited separately on the {010} and {110} facets of  $\text{BiVO}_4$  powder, respectively (Fig. 2e and f). XPS was utilized to check the oxidation state of silver and cobalt on  $\text{BiVO}_4$  crystals after dual component deposition. It was observed that two typical Ag 3d peaks (Ag  $3d_{5/2}$  and Ag  $3d_{3/2}$ ) of  $\text{BiVO}_4\text{-Ag/Co}_3\text{O}_4$  are located at the same position with that of the  $\text{BiVO}_4\text{-Ag}$  sample (Fig. 4b), and the two typical Co 2p peaks (Co  $2p_{1/2}$  and Co  $2p_{3/2}$ ) of the  $\text{BiVO}_4\text{-Ag/Co}_3\text{O}_4$  sample are also located at the same position with that of the  $\text{BiVO}_4\text{-Co}_3\text{O}_4$  sample (Fig. 4c). It was demonstrated that the selective deposition of Ag and  $\text{Co}_3\text{O}_4$  on two facets was successfully accomplished by the two-step photo-deposition procedure. Thus, the p-n junction and the m-s junction can be selectively constructed on hole and electron rich facets of  $\text{BiVO}_4$ . XPS is generally utilized to determine the content of single composition in the composite material. According to the XPS result in Fig. 4, the content of Ag and  $\text{Co}_3\text{O}_4$  loaded over  $\text{BiVO}_4$  can be calculated to be 2.026 wt% and 0.137 wt%, respectively.

### 3.2 Optical absorption properties

Diffuse reflectance spectroscopy is an appropriate tool to depict the energy band structure feature of a semiconductor, which is relevant to the optical absorption properties considered as a pivotal factor in determining its photocatalytic activity. Fig. 5a shows the UV-vis diffuse reflectance spectra of the four kinds of  $\text{BiVO}_4$  samples ( $\text{BiVO}_4$ ,  $\text{BiVO}_4\text{-Ag}$ ,  $\text{BiVO}_4\text{-Co}_3\text{O}_4$ , and  $\text{BiVO}_4\text{-Ag/Co}_3\text{O}_4$ ). The pure  $\text{BiVO}_4$  sample presents intense absorption in the visible region until  $\sim 525$  nm in addition to that in the UV light region.<sup>27,28</sup> For the monoclinic scheelite  $\text{BiVO}_4$ , the visible absorption band is designated to the transition from a valence band formed by Bi 6s or a hybrid orbital of Bi 6s and O 2p to a conduction band of V 3d.<sup>28</sup> The band gap ( $E_g$ ) of the sample can be estimated according to formula  $a h\nu = A(h\nu - E_g)^n$ ,<sup>28</sup> where  $a$ ,  $h$ ,  $\nu$ ,  $A$  and  $E_g$  are the absorption coefficient, Planck's constant, the incident light frequency, a constant and the band gap energy, respectively. For  $\text{BiVO}_4$ , the value of  $n$  is 1/2, which indicates that  $\text{BiVO}_4$  is a direct band gap material. From the plots of  $(a h\nu)^2$  versus photon energy ( $h\nu$ ) shown in Fig. 5b, the band gap energy of  $\text{BiVO}_4$  could be estimated to be 2.43 eV.<sup>29</sup>

After the deposition of  $\text{Co}_3\text{O}_4$ , the ability of light absorption is enhanced greatly. In accordance with that, the color of the sample changed from yellow of pure  $\text{BiVO}_4$  to grey-yellow of  $\text{BiVO}_4\text{-Co}_3\text{O}_4$  (Fig. 5c). This should be attributed to the broad absorption at 500–900 nm characteristic of the  $\text{Co}_3\text{O}_4$  phase.<sup>30</sup> After the deposition of Ag, the absorbance edge of  $\text{BiVO}_4\text{-Ag}$  shows a slight red shift, and the absorption of  $\text{BiVO}_4$  in the

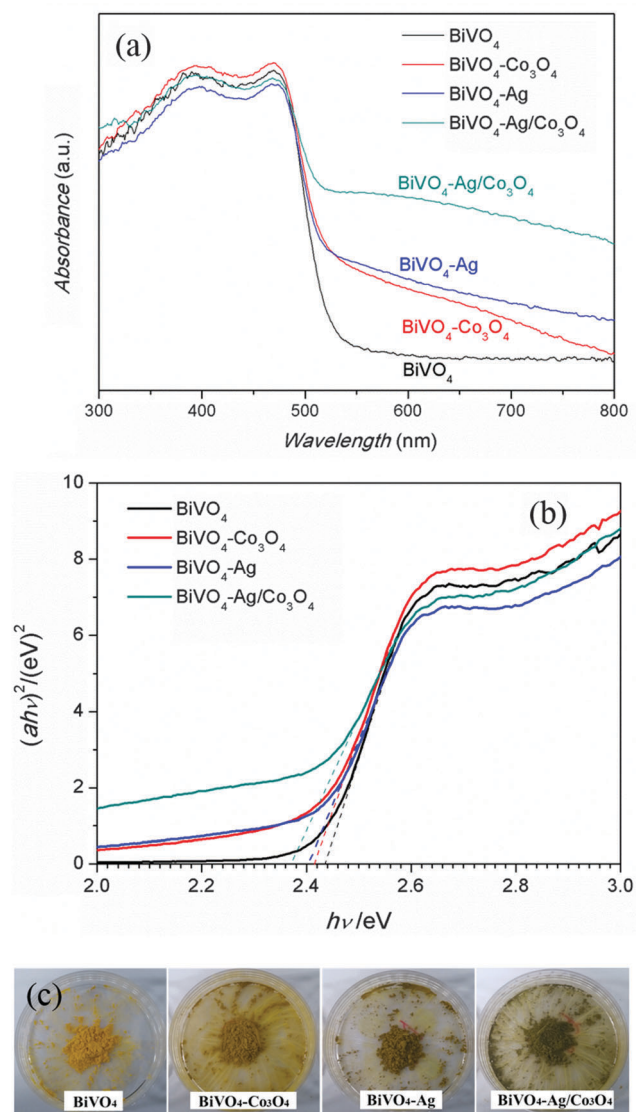


Fig. 5 UV-VIS DRS of samples BiVO<sub>4</sub>, BiVO<sub>4</sub>-Ag, BiVO<sub>4</sub>-Co<sub>3</sub>O<sub>4</sub>, and BiVO<sub>4</sub>-Ag/Co<sub>3</sub>O<sub>4</sub> (a), plots of  $(\alpha h\nu)^2$  vs.  $h\nu$  (b), and photos of samples BiVO<sub>4</sub>, BiVO<sub>4</sub>-Ag, BiVO<sub>4</sub>-Co<sub>3</sub>O<sub>4</sub>, and BiVO<sub>4</sub>-Ag/Co<sub>3</sub>O<sub>4</sub> (c).

range of 500–800 nm is intensified, both of it can be attributed to the surface plasmon resonance effect of silver nanoparticles.<sup>31</sup> After the deposition of two components (Ag and Co<sub>3</sub>O<sub>4</sub>), the absorption of BiVO<sub>4</sub> in the range of 500–800 nm is further enhanced in comparison with BiVO<sub>4</sub> samples deposited with a single Ag or single Co<sub>3</sub>O<sub>4</sub> component, and this result agrees with the phenomenon that the color of sample BiVO<sub>4</sub>-Ag/Co<sub>3</sub>O<sub>4</sub> is darker than samples BiVO<sub>4</sub>-Ag and BiVO<sub>4</sub>-Co<sub>3</sub>O<sub>4</sub>. It must be emphasized that the photocatalytic activity can be greatly increased when the band gap is narrowed, which can facilitate the generation of electrons and holes and the excitation of an electron from the valence band to the conduction band.<sup>32</sup> The estimated  $E_g$  of as-fabricated BiVO<sub>4</sub>-Co<sub>3</sub>O<sub>4</sub>, BiVO<sub>4</sub>-Ag and BiVO<sub>4</sub>-Ag/Co<sub>3</sub>O<sub>4</sub> from the intercept of the slopes to the plots were 2.41, 2.40 eV and 2.37 eV, respectively. The band gaps of these samples decreased compared to pure BiVO<sub>4</sub> (2.43 eV), and

the lower band gap implies a higher photocatalytic activity under visible light under irradiation in the presence of Ag and Co<sub>3</sub>O<sub>4</sub>.

### 3.3 Photocatalytic activity and the mechanism

To prove the contribution of Ag and Co<sub>3</sub>O<sub>4</sub> to the photocatalytic activities of BiVO<sub>4</sub>, and to understand the co-working mechanism of a multi-junction in a hybrid photocatalyst system, the photocatalytic activities of samples BiVO<sub>4</sub>, BiVO<sub>4</sub>-Ag, BiVO<sub>4</sub>-Co<sub>3</sub>O<sub>4</sub>, and BiVO<sub>4</sub>-Ag/Co<sub>3</sub>O<sub>4</sub> were firstly measured in the liquid phase reaction under the simulated solar light irradiation. The decomposition of RhB in the aqueous solution was chosen as the photoreaction probe. As shown in Fig. 6, the adsorption of RhB over all samples in dark condition could be neglected. After 120 min of the simulated solar light irradiation, the degradation extent of RhB dye with the assistance of pure BiVO<sub>4</sub> can only reach around 10%, indicating that BiVO<sub>4</sub> only achieves low activity for degradation of RhB. In the presence of BiVO<sub>4</sub> powders deposited with a single component (Ag or Co<sub>3</sub>O<sub>4</sub>),

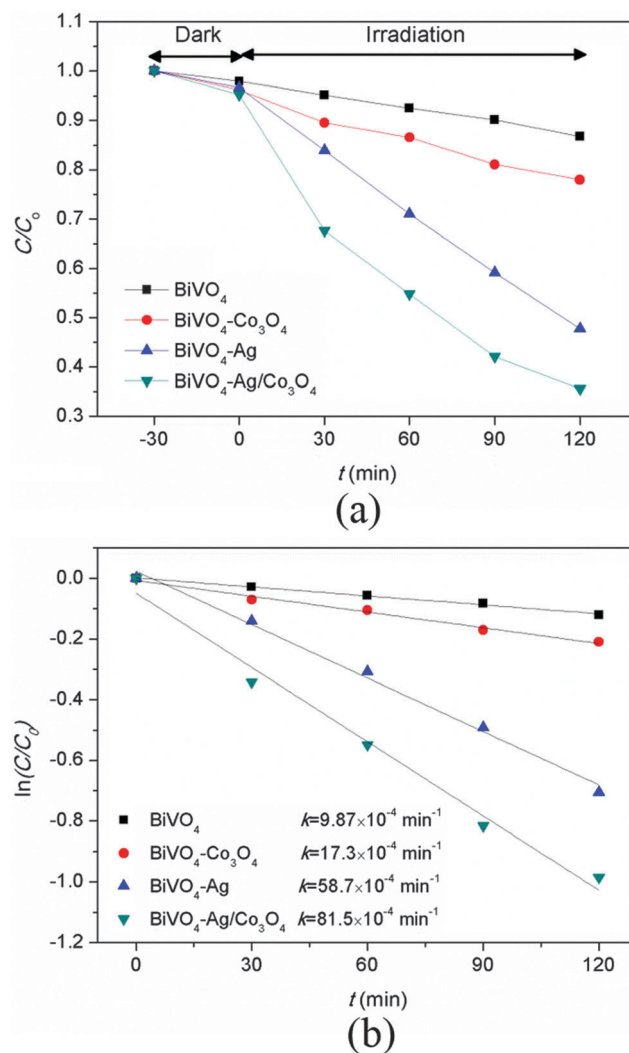


Fig. 6 Photo-degradation extent of RhB dye versus irradiation time in the presence of samples BiVO<sub>4</sub>, BiVO<sub>4</sub>-Co<sub>3</sub>O<sub>4</sub>, BiVO<sub>4</sub>-Ag, BiVO<sub>4</sub>-Ag/Co<sub>3</sub>O<sub>4</sub> (a), and kinetic curves of the photo-degradation of RhB dye under irradiation (b).

the degradation extents of RhB dye increase to 20% (sample BiVO<sub>4</sub>-Co<sub>3</sub>O<sub>4</sub>) and 52% (sample BiVO<sub>4</sub>-Ag), respectively. It indicates that the single Ag or Co<sub>3</sub>O<sub>4</sub> component on BiVO<sub>4</sub> powder can increase photocatalytic activities. In the presence of sample BiVO<sub>4</sub>-Ag/Co<sub>3</sub>O<sub>4</sub>, the degradation extent of RhB is further increased to 65%, proving that a better performance can be achieved by depositing the two components simultaneously.

If the photo-degradation of RhB is considered as a pseudo-first-order reaction, its photocatalytic reaction kinetics can be expressed as follows:  $\ln(C/C_0) = -kt$ , where  $C$  is the concentration of the RhB at time  $t$ ,  $C_0$  is the initial concentration of the RhB solution, and the slope  $k$  is the apparent reaction rate constant. Fig. 6b represents the photodegradation curves of RhB in the form of  $\ln(C_0/C)$  as a function of irradiation time. It can be found that the apparent reaction rate constant of sample BiVO<sub>4</sub> for RhB photo-degradation is  $9.87 \times 10^{-4} \text{ min}^{-1}$ . After depositing the two components (Ag and Co<sub>3</sub>O<sub>4</sub>) simultaneously, the apparent reaction rate constant of sample BiVO<sub>4</sub>-Ag/Co<sub>3</sub>O<sub>4</sub> for RhB photo-degradation increases to  $81.5 \times 10^{-4} \text{ min}^{-1}$ , which is almost ten times that of bare BiVO<sub>4</sub>. It is proven that the deposition of the two components can significantly improve the photoactivity of the photocatalyst. It should be noticed that the apparent reaction rate constant of sample BiVO<sub>4</sub>-Ag/Co<sub>3</sub>O<sub>4</sub> is almost equal to the sum of that of samples BiVO<sub>4</sub>-Ag and BiVO<sub>4</sub>-Co<sub>3</sub>O<sub>4</sub> ( $k_{\text{BiVO}_4\text{-Ag/Co}_3\text{O}_4} \approx k_{\text{BiVO}_4\text{-Ag}} + k_{\text{BiVO}_4\text{-Co}_3\text{O}_4}$ ), indicating that there is no synergetic effect between the p-n junction and the metal-semiconductor junction in the Co<sub>3</sub>O<sub>4</sub>/BiVO<sub>4</sub>/Ag system.

PL emission spectra are often used to examine the efficiency of charge carrier trapping, immigration and transfer, as well as to understand the fate of electron/hole pairs in semiconductor particles. Fig. 7 shows the room temperature PL emission spectra of samples BiVO<sub>4</sub>, BiVO<sub>4</sub>-Co<sub>3</sub>O<sub>4</sub>, BiVO<sub>4</sub>-Ag, and BiVO<sub>4</sub>-Ag/Co<sub>3</sub>O<sub>4</sub>. The PL peak of as-fabricated BiVO<sub>4</sub> powder was observed at around 540 nm, and it corresponds to the recombination of the hole formed in the O 2p band and the electron in the V 3d band. In comparison with bare BiVO<sub>4</sub>, the PL peak is reduced

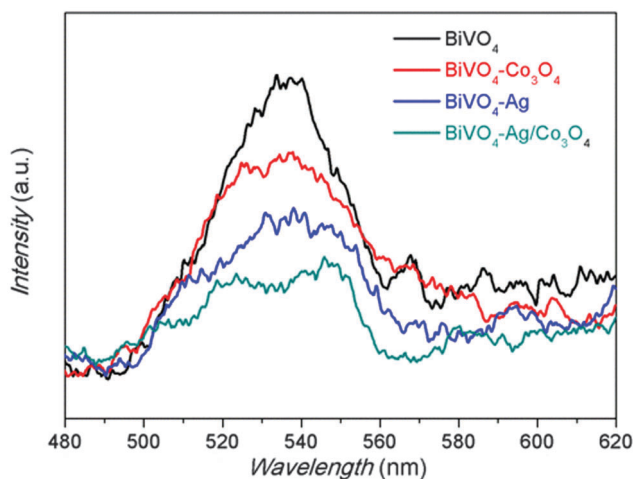


Fig. 7 Room temperature PL emission spectra of samples BiVO<sub>4</sub>, BiVO<sub>4</sub>-Co<sub>3</sub>O<sub>4</sub>, BiVO<sub>4</sub>-Ag, and BiVO<sub>4</sub>-Ag/Co<sub>3</sub>O<sub>4</sub>.

after depositing a single Co<sub>3</sub>O<sub>4</sub> or single Ag component, indicating that the existence of the single component can help to reduce the recombination of electrons and holes. The PL peak of the sample BiVO<sub>4</sub>-Ag/Co<sub>3</sub>O<sub>4</sub> is further reduced after depositing Ag and Co<sub>3</sub>O<sub>4</sub> simultaneously. This result indicates that the recombination of photogenerated charge carriers is greatly inhibited, and photo-activity of the photocatalyst will be enhanced greatly after depositing Ag and Co<sub>3</sub>O<sub>4</sub> simultaneously.

Based on these results, the charge separation process of Ag/BiVO<sub>4</sub>/Co<sub>3</sub>O<sub>4</sub> heterogeneous structures can be proposed as Fig. 8. The band gap of BiVO<sub>4</sub> was evaluated to be 2.43 eV from the UV-vis spectrum. Therefore we presume the corresponding conduction band ( $E_{\text{CB}}$ ) and valence band ( $E_{\text{VB}}$ ) positions of BiVO<sub>4</sub> at the point of zero charge through the following equations:<sup>33</sup>

$$E_{\text{CB}} = x - E_0 - \frac{1}{2}E_{\text{g}} \quad (5)$$

$$x = \frac{1}{2}(A_{\text{f}} + I_1) \quad (6)$$

where  $x$  is the bulk electronegativity of the compound,  $A_{\text{f}}$  and  $I_1$  are the atomic electron affinity and the first ionization potential, respectively.  $E_0$  is the energy of free electrons on the hydrogen scale (about 4.5 eV), and  $E_{\text{g}}$  is the band gap energy of the semiconductor. The position of the valence band edge can be determined by the equation of  $E_{\text{VB}} = E_{\text{CB}} + E_{\text{g}}$ . The calculation result shows that the bottom of the conduction band of BiVO<sub>4</sub> is around 0.32 eV versus the normal hydrogen electrode (NHE), while the top of the valence band is around 2.75 eV. Generally speaking, the conduction band potential of an n-type semiconductor is more negative (*ca.* 0.1–0.2 V) than the flat-band potentials,<sup>33</sup> so the Fermi level of metallic Ag ( $E_{\text{f}} = 0.69 \text{ V vs. NHE}$ ) is much lower than that of BiVO<sub>4</sub>.<sup>34</sup> On the {010} facet of BiVO<sub>4</sub>, when Ag and BiVO<sub>4</sub> are in contact, electrons in BiVO<sub>4</sub> will transfer to the Ag particles to equilibrate the Fermi levels, and a Schottky barrier forms between Ag and BiVO<sub>4</sub>. Furthermore, it was widely reported that Co<sub>3</sub>O<sub>4</sub> is a kind of p-type semi-conductor with a conduction band edge and a valence band edge of Co<sub>3</sub>O<sub>4</sub> of 0.37 eV and 2.44 eV vs. NHE. Before contact of p-type Co<sub>3</sub>O<sub>4</sub> with n-type BiVO<sub>4</sub>, the conduction band edge of p-type Co<sub>3</sub>O<sub>4</sub> is lower than that of n-type BiVO<sub>4</sub>, and the Fermi level of Co<sub>3</sub>O<sub>4</sub> is also lower than that of BiVO<sub>4</sub>, as shown in Fig. 8a. After the p-type Co<sub>3</sub>O<sub>4</sub> nanoparticles are tightly assembled on the hole-rich facet {110} of n-type BiVO<sub>4</sub> nanocrystals, the Fermi level of Co<sub>3</sub>O<sub>4</sub> is increased up, while the Fermi level of BiVO<sub>4</sub> is lowered until an equilibrium state is formed as shown in Fig. 8b. Meanwhile, with increasing and/or lowering the Fermi level, the whole energy band of Co<sub>3</sub>O<sub>4</sub> is increased while that of BiVO<sub>4</sub> is lowered, and as a result, the conduction band edge of p-type Co<sub>3</sub>O<sub>4</sub> is higher than that of n-type BiVO<sub>4</sub>, leading to the formation of a p-n junction at the interface between Co<sub>3</sub>O<sub>4</sub> and BiVO<sub>4</sub> crystals.

In the Ag/BiVO<sub>4</sub>/Co<sub>3</sub>O<sub>4</sub> system, the electrons and holes transfer separately to {010} and {110} facets of BiVO<sub>4</sub> for the potential difference between the two facets under irradiation. On the electron-rich {010} facet, electrons can be easily injected

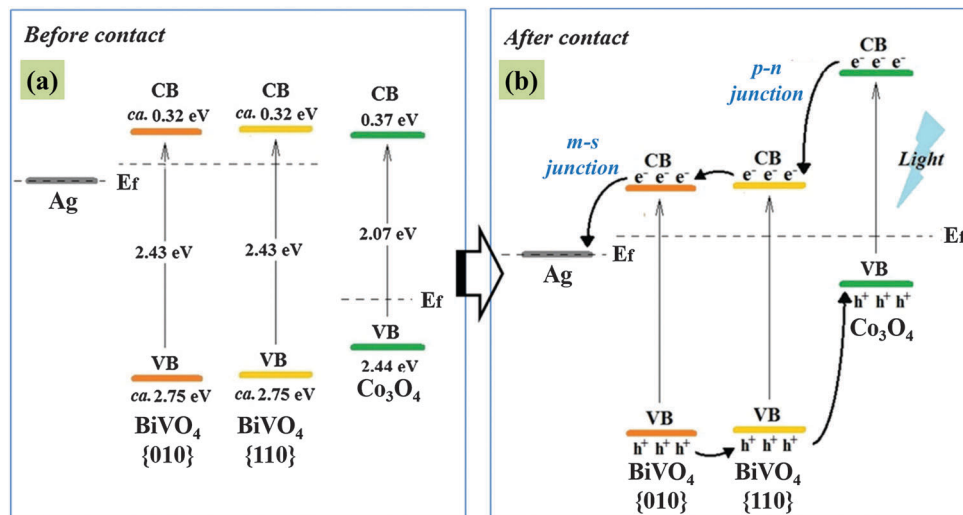


Fig. 8 A schematic on the charge transfer processes of the Ag/BiVO<sub>4</sub>/Co<sub>3</sub>O<sub>4</sub> hybrid photocatalyst.

into the Fermi level of Ag. The metallic silver nanoparticles functioned as an electron sink to accept the photo-generated electrons from the excited semiconductor, thereby facilitating dioxygen reduction.<sup>35</sup> On the hole-rich {110} facet, the photo-generated holes on the valence band of n-type BiVO<sub>4</sub> can be promptly migrated to the valence band of p-type Co<sub>3</sub>O<sub>4</sub>, and the photo-generated electrons on the conduction band of p-type Co<sub>3</sub>O<sub>4</sub> can be transferred to the conduction band of n-type BiVO<sub>4</sub>. Such a migration of photo-generated carriers can be promoted by the internally formed electric field. Therefore, the photo-generated electrons and holes of n-type BiVO<sub>4</sub> can be separated effectively by the p–n junctions formed between the p-type Co<sub>3</sub>O<sub>4</sub> and the n-type BiVO<sub>4</sub> interface, and the recombination of electron–hole pairs can be substantially reduced. As a result, Ag/BiVO<sub>4</sub>/Co<sub>3</sub>O<sub>4</sub> had a quicker charge separation and a slower charge recombination process than the single or two component catalyst system. The combination of the two junctions in the Ag/BiVO<sub>4</sub>/Co<sub>3</sub>O<sub>4</sub> system results in additional effect for improving photo-activity.

## 4. Conclusion

A novel ternary Ag/BiVO<sub>4</sub>/Co<sub>3</sub>O<sub>4</sub> hybrid photocatalyst was designed by the photo-deposition method. In this hybrid photocatalyst, a metal–semiconductor junction and a p–n junction were separately constructed over {010} facets and {110} facets of BiVO<sub>4</sub>, which are electron-rich and hole-rich facets, respectively. The Ag/BiVO<sub>4</sub>/Co<sub>3</sub>O<sub>4</sub> system exhibits enhanced photocatalytic activity for rhodamine B degradation, which is over 8 times that of bare BiVO<sub>4</sub> under irradiation. The apparent reaction rate constant of sample BiVO<sub>4</sub>-Ag/Co<sub>3</sub>O<sub>4</sub> is almost equal to the sum of that of samples BiVO<sub>4</sub>-Ag and BiVO<sub>4</sub>-Co<sub>3</sub>O<sub>4</sub>. It is proven that the combination of the two junctions further promotes the charge transferring across the interface, and results in an additional effect of the two single junctions for improving photo-activity. This research provides a deep insight about the co-working mechanism between two heterojunctions, and

it will propose a new concept for designing a highly efficient photocatalyst system.

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